

Individual Characterization

Near-Field Probe Characterization

Short description

The characterization service for our near-field probes includes:

The determination of the transfer function of the near-field probe on a special microstrip line that guarantees a defined field distribution.

Furthermore, correction values are generated from this measurement data to more accurately determine the measured field strength values.

You will receive the measurement data, the correction values for the ChipScan-ESA software, and as a value table, and a certificate of successful frequency response determination.

Scope of delivery

1x USB, USB Flash Drive